

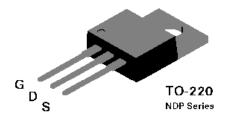
NDP7050 / NDB7050 N-Channel Enhancement Mode Field Effect Transistor

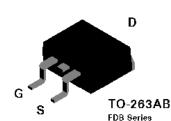
General Description

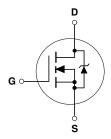
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC/DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 75A, 50V. $R_{DS(ON)} = 0.013\Omega$ @ $V_{GS} = 10V$.
- Critical DC electrical parameters specified at elevated temperature.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.
- High density cell design for extremely low R_{DS(ON)}.
- TO-220 and TO-263 (D²PAK) package for both through hole and surface mount applications.







Absolute Maximum Ratings T_c = 25°C unless otherwise noted

Symbol	Parameter	NDP7050	NDB7050	Units	
V _{DSS}	Drain-Source Voltage		V		
V _{DGR}	Drain-Gate Voltage ($R_{GS} \le 1 \text{ M}\Omega$)		V		
V _{GSS}	Gate-Source Voltage - Continuous	<u>+</u>	V		
	- Nonrepetitive ($t_P < 50 \mu s$)	<u>+</u>			
I _D	Drain Current - Continuous		А		
	- Pulsed	2			
P _D	Maximum Power Dissipation @ T _C = 25°C	er Dissipation @ $T_C = 25^{\circ}C$			
	Derate above 25°C		W/°C		
T _J ,T _{STG}	Operating and Storage Temperature Range	-65	to 175	.€	
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	2	275	.€	

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
DRAIN-S	OURCE AVALANCHE RATINGS (Note 1)	·					
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 25 \text{ V}, I_{D} = 75 \text{ A}$				550	mJ
I _{AR}	Maximum Drain-Source Avalanche Curre			75	Α		
OFF CH	ARACTERISTICS						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0~V,~I_{D}=250~\mu A$		50			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	T _. = 125°C			250 1	μA mA
I _{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	U			100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
ON CHAP	RACTERISTICS (Note 1)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		2	2.8	4	V
			$T_{J} = 125^{\circ}C$	1.4	2.1	3.6	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_{D} = 40 \text{ A}$	·		0.01	0.013	Ω
			$T_J = 125$ °C			0.023	
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$	•	75			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 37.5 \text{ A}$		15	39		S
DYNAMIC	CHARACTERISTICS						
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			2960	3600	рF
C _{oss}	Output Capacitance	f = 1.0 MHz			1130	1600	pF
C _{rss}	Reverse Transfer Capacitance				380	800	pF
SWITCHI	NG CHARACTERISTICS (Note 1)	-		I.			
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 30 \text{ V}, I_D = 75 \text{ A},$			17	30	nS
ţ,	Turn - On Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 5 \Omega$			128	400	nS
$t_{D(off)}$	Turn - Off Delay Time				54	80	nS
ţ,	Turn - Off Fall Time				90	200	nS
Q_g	Total Gate Charge	$V_{DS} = 48 \text{ V},$ $I_D = 75 \text{ A}, V_{GS} = 10 \text{ V}$			100	115	nC
Q_{gs}	Gate-Source Charge	$I_D = 75 \text{ A}, \ V_{GS} = 10 \text{ V}$			14.5		nC
Q _{gd}	Gate-Drain Charge				51		nC

Symbol	Parameter	Min	Тур	Max	Units		
DRAIN-S	OURCE DIODE CHARACTERISTICS					•	•
I _s	Maximum Continuos Drain-Source Diode			75	Α		
SM	Maximum Pulsed Drain-Source Diode Fo			225	Α		
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 37.5 A (Note 1)			0.9	1.3	V
			$T_J = 125^{\circ}C$		0.84	1.2	
m	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_F = 75 \text{ A}, dI_F/dt = 100 \text{ A}$	A/μs		80	150	ns
m	Reverse Recovery Current			2	4.8	10	Α
ΓHERMA	L CHARACTERISTICS						
R _{euc}	Thermal Resistance, Junction-to-Case					1	°C/W
R _{OJA}	Thermal Resistance, Junction-to-Ambient			62.5	°C/W		

Note: 1. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics

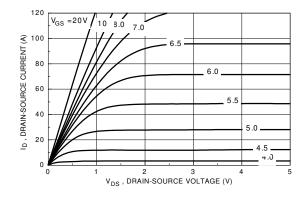
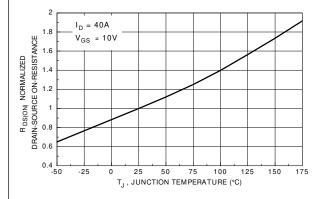


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.



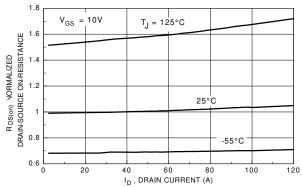
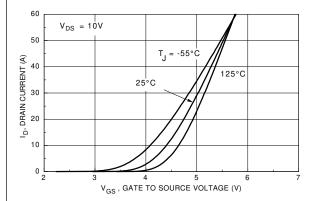


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Drain Current and Temperature.



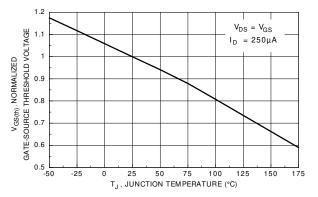


Figure 5. Transfer Characteristics.

Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics (continued)

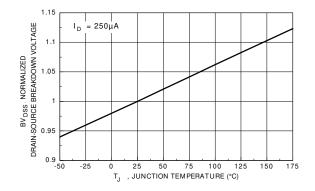


Figure 7. Breakdown Voltage Variation with Temperature.

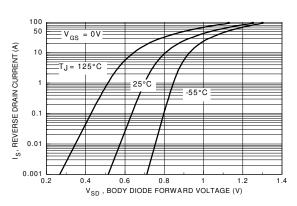


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

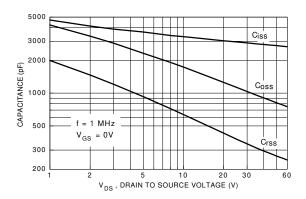


Figure 9. Capacitance Characteristics.

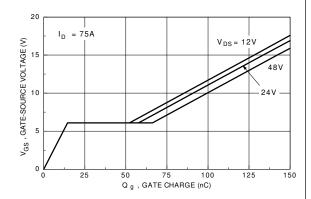


Figure 10. Gate Charge Characteristics.

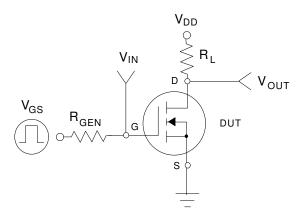


Figure 11. Switching Test Circuit.

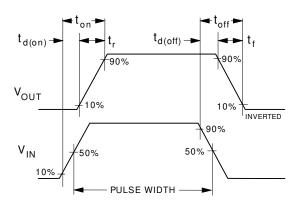
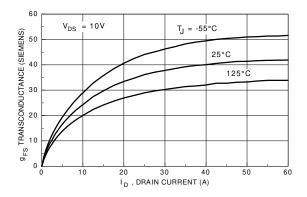


Figure 12. Switching Waveforms.

Typical Electrical Characteristics (continued)



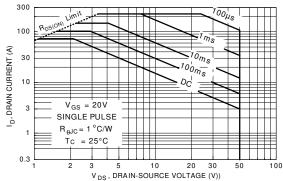


Figure 13. Transconductance Variation with Drain Current and Temperature.

Figure 14. Maximum Safe Operating Area.

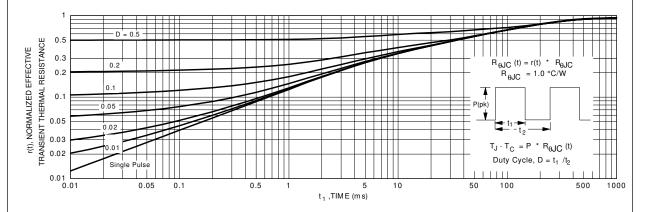
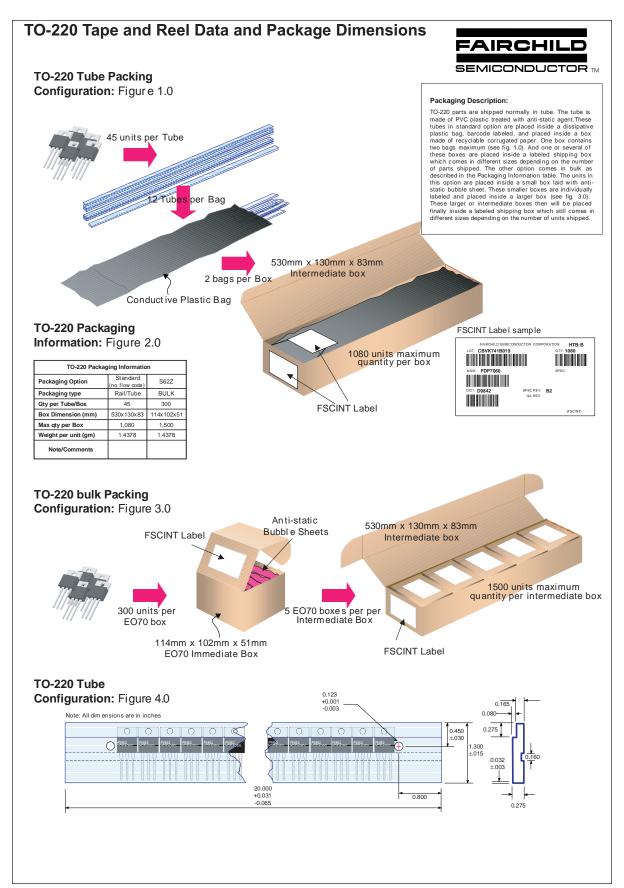
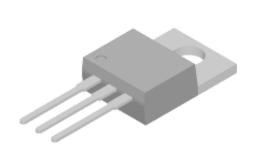


Figure 15. Transient Thermal Response Curve.

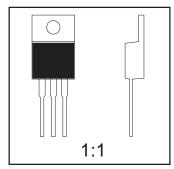


TO-220 Tape and Reel Data and Package Dimensions, continued

TO-220 (FS PKG Code 37)

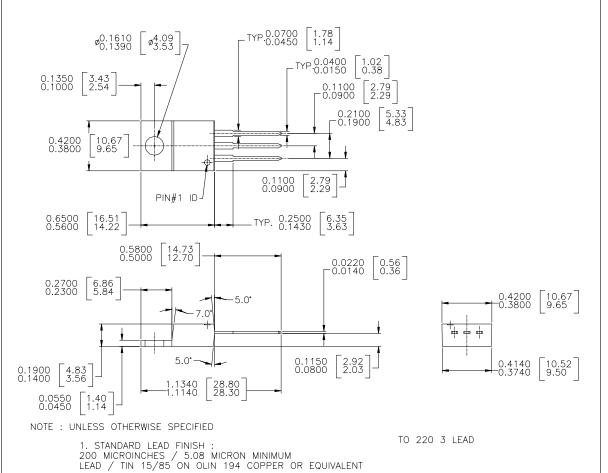


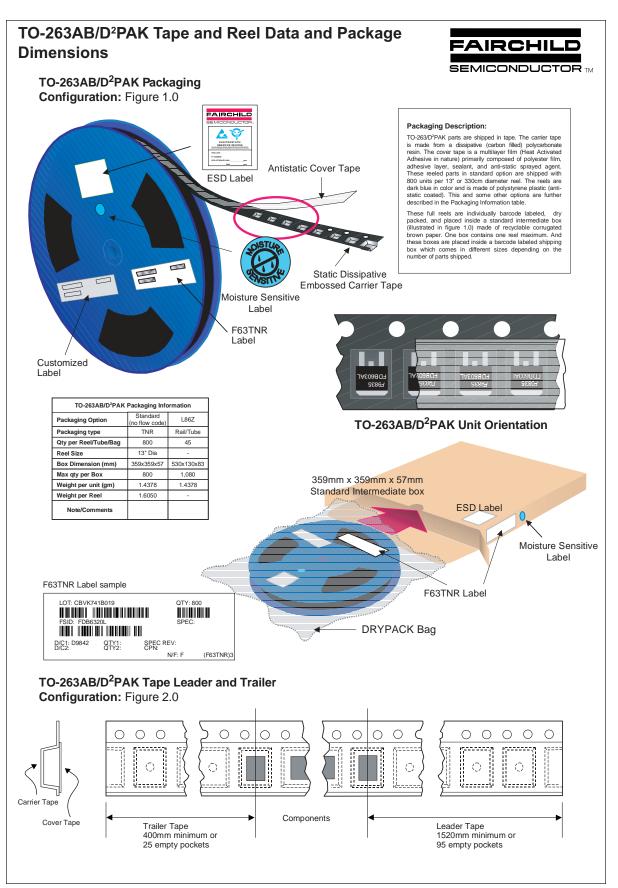
2. DIMENSION BASED ON JEDEC STANDARD TO-220 VARIATION AB, ISSUE J, DATED 3/24/87



Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

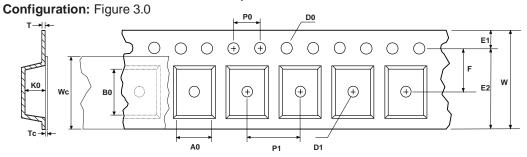
Part Weight per unit (gram): 1.4378





TO-263AB/D²PAK Tape and Reel Data and Package Dimensions, continued

TO-263AB/D²PAK Embossed Carrier Tape



User Direction of Feed

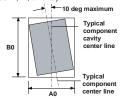
Dimensions are in millimeter														
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	Т	Wc	Тс
TO263AB/ D ² PAK (24mm)	10.60 +/-0.10	15.80 +/-0.10	24.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	22.25 min	11.50 +/-0.10	16.0 +/-0.1	4.0 +/-0.1	4.90 +/-0.10	0.450 +/-0.150	21.0 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)

Component Rotation



Sketch B (Top View)
Component Rotation

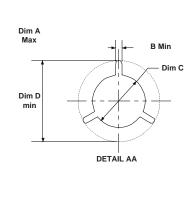
W1 Measured at Hub



Sketch C (Top View)
Component lateral movement

TO-263AB/D²PAK Reel Configuration: Figure 4.0





13" Diameter Option

W2 max Measured at Hub

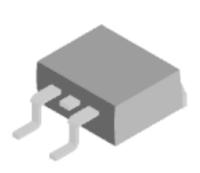
Dim N

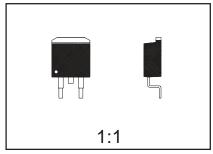
See detail AA

Dimensions are in inches and millimeters									
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
24mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	4.00 100	0.961 +0.078/-0.000 24.4 +2/0	1.197 30.4	0.941 - 0.1.079 23.9 - 27.4

TO-263AB/D²PAK Tape and Reel Data and Package Dimensions, continued

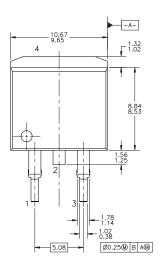
TO-263AB/D²PAK (FS PKG Code 45)

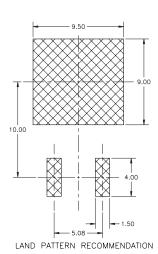


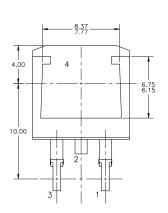


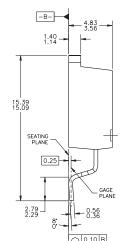
Scale 1:1 on letter size paper Dimensions shown below are in: inches [millimeters]

Part Weight per unit (gram): 1.4378









- NOTES: UNLESS OTHERWISE SPECIFIED

 A) ALL DIMENSIONS ARE IN MILLIMETERS.
 B) STANDARD LEAD FINISH:
 200 MICROINCHES / 5.08 MICROMETERS MIN.
 LEAD/TIN 15/85 ON OLIN 194 COPPER OR
 EQUIVALENT.
 C) MAXIMUM YERTICAL BURR ON HEATSINK NOT
 TO EXCEED 0.003 INCH / 0.05mm.
 D) NO PACKAGE CHIPS, CRACKS OR SURFACE
 IDENTIFICATION ALLOWED AFTER FORMING.
 E) REFERENCE JEDEC, TO—265, ISSUE C,
 VARIATION AB, DATED 2/92.

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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